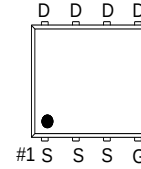
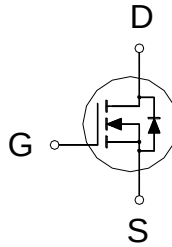




PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
60V	9.8m Ω	47A



G. GATE
D. DRAIN
S. SOURCE

ABSOLUTE MAXIMUM RATINGS ($T_A = 25\text{ }^{\circ}\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Drain-Source Voltage		V_{DS}	60	V
Gate-Source Voltage		V_{GS}	± 20	V
Continuous Drain Current	$T_C = 25\text{ }^{\circ}\text{C}$	I_D	47	A
	$T_C = 100\text{ }^{\circ}\text{C}$		33	
Pulsed Drain Current ¹		I_{DM}	91	
Continuous Drain Current	$T_A = 25\text{ }^{\circ}\text{C}$	I_D	17	
	$T_A = 70\text{ }^{\circ}\text{C}$		14	
Avalanche Current		I_{AS}	28	
Avalanche Energy	$L = 0.1\text{mH}$	E_{AS}	40	mJ
Power Dissipation	$T_C = 25\text{ }^{\circ}\text{C}$	P_D	39	W
	$T_C = 100\text{ }^{\circ}\text{C}$		20	
Power Dissipation ³	$T_A = 25\text{ }^{\circ}\text{C}$	P_D	5	W
	$T_A = 70\text{ }^{\circ}\text{C}$		3.5	
Operating Junction & Storage Temperature Range		T_j, T_{stg}	-55 to 175	$^{\circ}\text{C}$

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE		SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient ²	$t \leq 10\text{s}$	$R_{\theta JA}$		30	$^{\circ}\text{C} / \text{W}$
Junction-to-Ambient ²	Steady-State	$R_{\theta JA}$		50	
Junction-to-Case	Steady-State	$R_{\theta JC}$		3.8	

¹Pulse width limited by maximum junction temperature.

²The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^{\circ}\text{C}$.

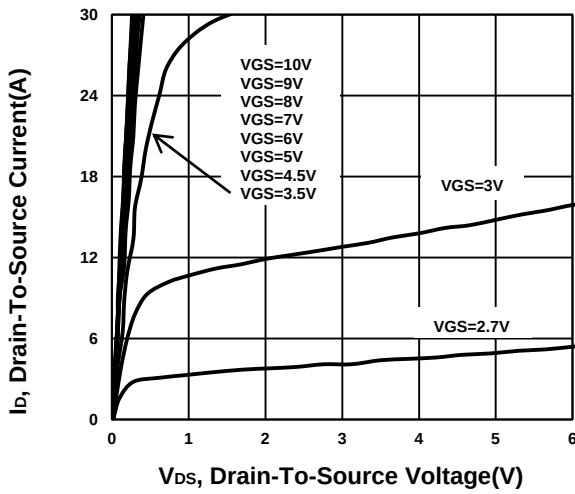
³The Power dissipation is based on $R_{\theta JA}$ $t \leq 10\text{s}$ value.

ELECTRICAL CHARACTERISTICS ($T_J = 25\text{ }^{\circ}\text{C}$, Unless Otherwise Noted)

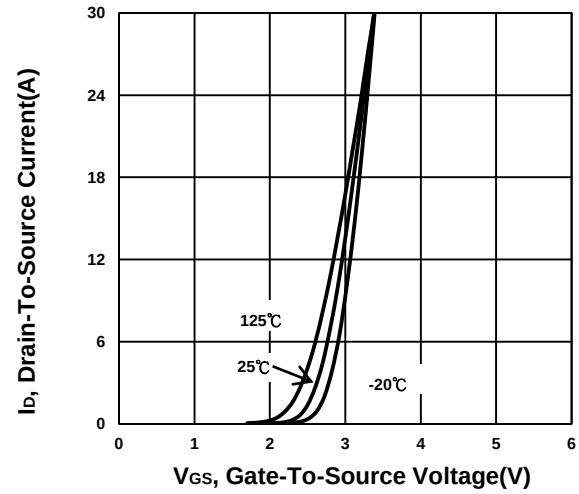
PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	60			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	1	1.75	3	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0V, V_{GS} = \pm 20V$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 60V, V_{GS} = 0V$			1	μA
		$V_{DS} = 60V, V_{GS} = 0V, T_J = 55\text{ }^{\circ}C$			10	
Drain-Source On-State Resistance ¹	$R_{DS(ON)}$	$V_{GS} = 10V, I_D = 20A$		8.1	9.8	m Ω
		$V_{GS} = 4.5V, I_D = 20A$		12	16	
Forward Transconductance ¹	g_{fs}	$V_{DS} = 5V, I_D = 20A$		43		S
DYNAMIC						
Input Capacitance	C_{iss}	$V_{GS} = 0V, V_{DS} = 30V, f = 1MHz$		1111		pF
Output Capacitance	C_{oss}			574		
Reverse Transfer Capacitance	C_{rss}			27		
Gate Resistance	R_g	$V_{GS} = 0V, V_{DS} = 0V, f = 1MHz$		1.2		Ω
Total Gate Charge ²	Q_g	$V_{DS} = 30V, V_{GS} = 10V, I_D = 20A$	$V_{GS} = 10V$	18		nC
			$V_{GS} = 4.5V$	9.8		
Gate-Source Charge ²	Q_{gs}			3.3		
Gate-Drain Charge ²	Q_{gd}			4.3		
Turn-On Delay Time ²	$t_{d(on)}$	$V_{DS} = 30V, I_D \cong 20A, V_{GS} = 10V, R_{GEN} = 6\Omega$		11		nS
Rise Time ²	t_r			55		
Turn-Off Delay Time ²	$t_{d(off)}$			26		
Fall Time ²	t_f			100		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_J = 25\text{ }^{\circ}C$)						
Continuous Current	I_S				33	A
Forward Voltage ¹	V_{SD}	$I_F = 20A, V_{GS} = 0V$			1.2	V
Reverse Recovery Time	t_{rr}	$I_F = 20A, dI_F/dt = 100A / \mu S$		25		nS
Reverse Recovery Charge	Q_{rr}			12		nC

¹Pulse test : Pulse Width $\leq 300\text{ }\mu\text{sec}$, Duty Cycle $\leq 2\%$.²Independent of operating temperature.

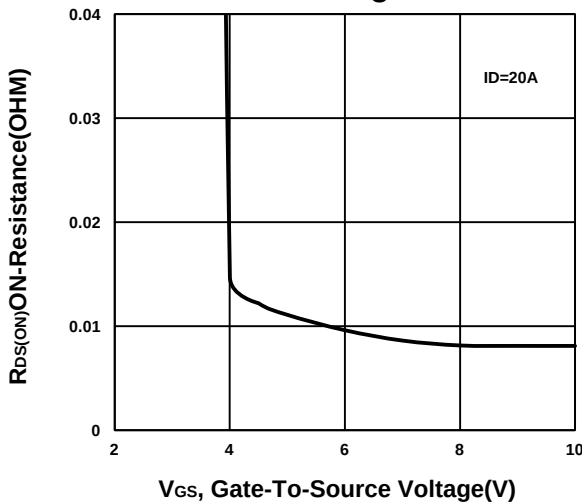
Output Characteristics



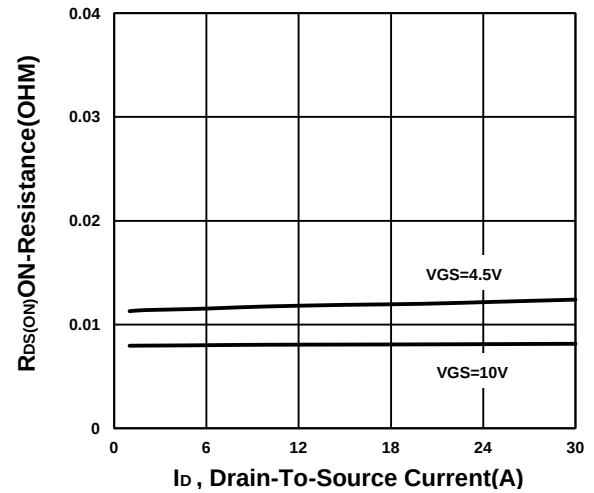
Transfer Characteristics



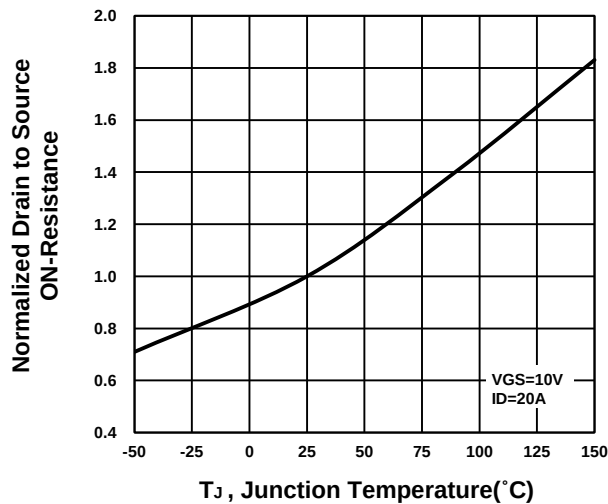
On-Resistance VS Gate-To-Source Voltage



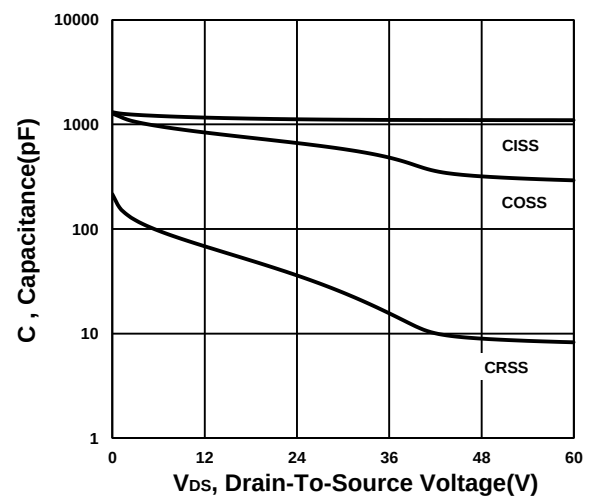
On-Resistance VS Drain Current



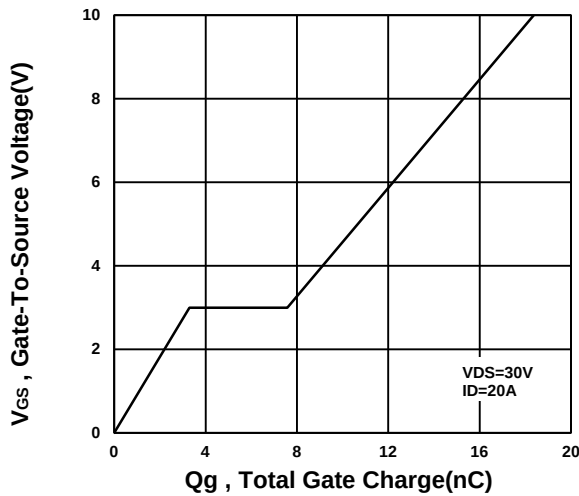
On-Resistance VS Temperature



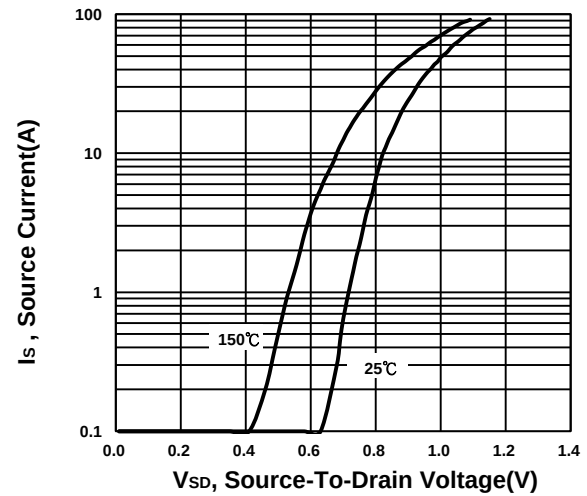
Capacitance Characteristic



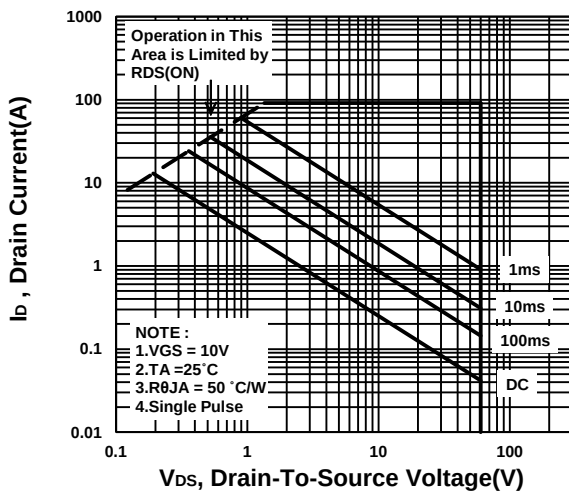
Gate charge Characteristics



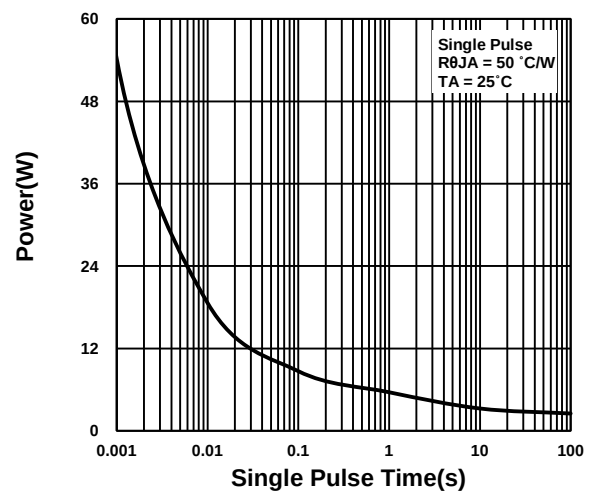
Source-Drain Diode Forward Voltage



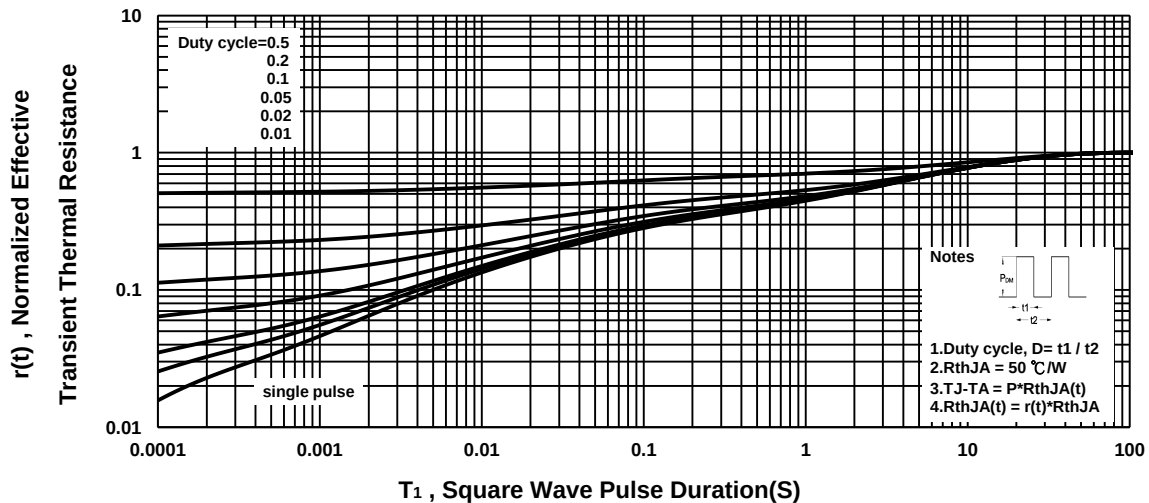
Safe Operating Area



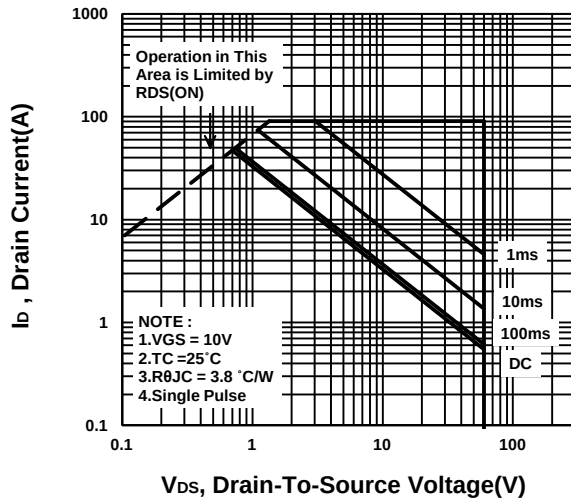
Single Pulse Maximum Power Dissipation



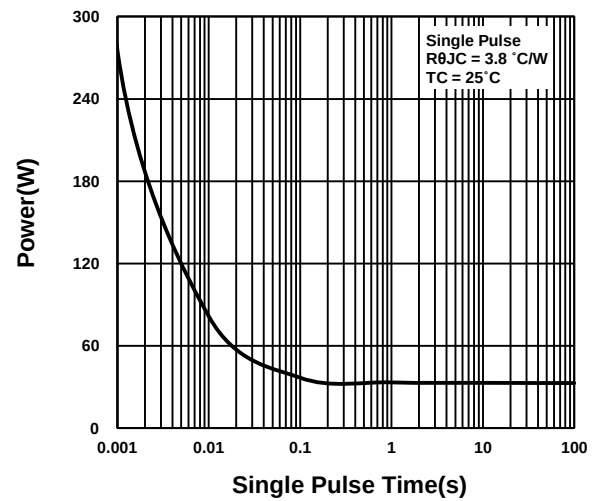
Transient Thermal Response Curve



Safe Operating Area



Single Pulse Maximum Power Dissipation



Transient Thermal Response Curve

